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Crystal Instruments Help - https://help.go-ci.com/

VCS Swept Sine Testing

Selects

Create New Test

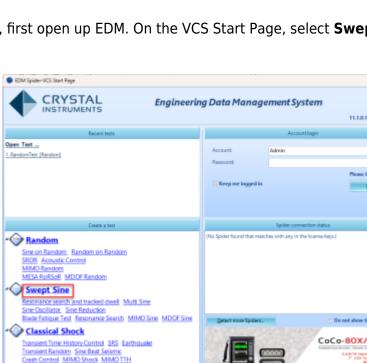
To create a new test, first open up EDM. On the VCS Start Page, select Swept Sine under the Create a test tab.

1/12

CRYSTAL INSTRUMENTS Engineering Data Management System 11.1.0.15 Open Test ... Account Admi 1. RandomTest [Random] T Ke any in the lic · 💮 <u>Random</u> Sine on Random, Bandom on Random SROR, Acoustic Control MIMO Random MESA RoRSoR, MDDF Random Swept Sine ance search and tracked dwell. Multi Sine ne Oscillator Sine Reduction Jade Fatique Test Resonance Search MIMO Sine MDOF Sine Do not show this start p Classical Shock CoCo-80X/90X Transient Time History Control SRS Earthquake 1 2.4.8/16 Input Channel 7º 120 Trusterem Will FL & CPS Care But Transient Bandom Sine Beat Seismic Crash Control MIMO Shock MIMOTTH MIMO SRS Time waveform replication MIMO TWR

The New Test Wizard will now open up. From here, select Swept Sine again and then press Next.

Finally, give the test	a name and select the Spider system that will be used to run the test. Once all is
complete, press Crea	ite.





lev Test Wated					- 2
	information for te able to search f	this test to this test by "Test name" or "Test description	6		
	ept Snetest Sile	efeat			
Test names	\$inefest		E Append the sequence number		
Test description					
· Use the dat	NUT HERE OF TH	e previous test of the same type. If default Hor	aries were not applied before the manufacturing settings will be used.		
Creater less 1	ly using a templat				
Select Ter	plate name	Description			
	515,2597304				
Spider system					
fest directory:	C/(DieV(Diev))	Documents' SDMI, demoi / Sinellest	Choose		
V Gratemen n	in fulder for each	run			
			Tark Cred	e test 👘 Ca	had

Test Configuration

The test will now need to be configured to run. This includes inputting information regarding the shaker, creating the schedule for the test to follow, and determining the parameters for the frequency analysis. To access the **Test Configuration** menu, press the **Config** button that can be found on the right side of the screen.



Shaker Parameters

Click on **Edit Parameters** and enter the information from the shaker specifications. This is important for the safety of the shaker and testing unit.

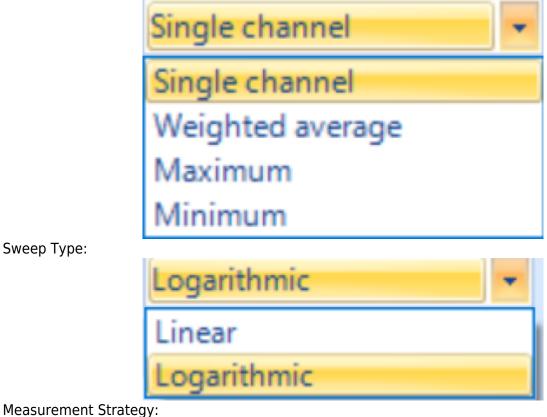
			? >
haker details			
Manufacturer Anonymous		Shaker name Default Shaker	
orce and acceleration			
Random Max. Force RMS (LBF)	100.022	Random Max. Acc. RMS (g)	16.66667
ine Max. Force Peak (LBF)	2205.866	Sine Max. Acc. Peak (g)	75
ihock Max. Force Peak (LBF)	100.022	Shock Max. Acc. Peak (g)	50
isplacement			
Max. positive displacement (mm)	6.35	Max. negative displacement (mm)	6.35
eneral settings			
Max. drive voltage peak (V)	10	Max. velocity (m/s)	1.778
Min. drive frequency (Hz)	1	Max. drive frequency (Hz)	2500
ihaker orientation	Vertical 🔹		
haker moving mass			
Armature mass (Ib)	0.4409245	Header expander (lb) 🧵	0
ilip table (lb) 🖶	0 -	Drive bar (lb) 🙌	0
Calc. acc. using force	0 +	Drive bar (Ib) 🛏	ill he es esti

Test Parameters

The **Test parameters** section in the **Test Configuration** window has settings for the analysis parameters, abort sensitivities and control strategy.

G Test Configurations for SineTest [Swept Sine]						?	×
Shaker parameters «	Shaker information							
Shaker parameters								
Test parameters	Manufacturer	Anony	mous					
Test profile	Shaker name	Default	t Shaker					
Check against shaker	Payload mass		0.22046	в				
Run schedule	Fixture mass		0	Ць				
Limit channels			0	1				
Event actions	Actual shaker limits used in this test						-	
File directory	Force peak		2205.9	LBF	0			
Save/Recording setup								
Output settings	Acceleration peak		75	9	•			
	Max. velocity		1.778	m/s	Ø			
	Max. positive displacement		6.35	mm	0			
	Max. negative displacement		6.35	mm	0			
	Shaker orientation		Vertical					
	Max. drive voltage peak		10	۷				
	Min. drive frequency		1	Hz				
	Max. drive frequency		2500	Hz				
	Shaker moving mass		0.44092	lb				
	limit is adjusted by the follow Actual Acc. = Min(Shaker pa	ing fact Iram. Fo	or: orce / (Armature mass	+ Paj	Edit parameters" to view or edit sha rload mass + other mass), Shaker pa ended range within 10240 Hz.		celeratio	on
	Load from library Save to libra	ry Imp	port manufacturer shall	oer lis	Export manufacturer shaker list	Import default library		
Config. library •						QK	Cance	el

Control Strategy: Determines whether one or multiple control channels are used, and how the composite control signal is generated (if multiple channels are used).



Measurement Strategy:

Measurement strategy:	Filter 🔹
	Filter
	RMS
Filter type	Mean
Proportional Filter	Peak

Test Profile

The test profile is defined in the Test Profile section of the Test Configuration window. A graphical preview of the profile plot is displayed above, with a breakpoint table below for entering the profile. CSV import / export is also supported as an alternative to profile editing.

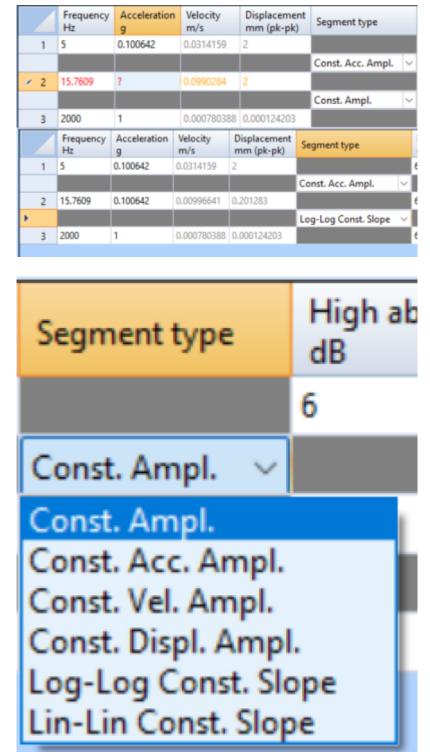
Acceleration Velocity Displacement Segment High abort High a		Acc/Vel/Displ
Insert row Delete row Append row Clear table Fill * Import/Export profile * Edit Table * Utput settings		
st profile neck against shaker an schedule mit channels rent actions le directory we/Recording setup utput settings Frequency Acceleration Velocity Displacement Segment High abort High		
neck against shaker un schedule 0.1 mit channels rent actions 0.01 le directory we/Recording setup utput settings Insert row Delete row Append row Clear table Fill * Insert row Delete row Append row Clear table Frequency Acceleration Velocity Displacement Segment High abort		
un schedule mit channels ent actions le directory we/Recording setup utput settings Frequency Acceleration Velocity Displacement Segment High abort High abort Hi		
In schedule 0.01 Intert row Delete row Append row Clear table Fill * Import/Export profile * Edit Table * stput settings Frequency Acceleration Velocity Displacement Segment High abort High al		
ent actions ent actions e directory ve/Recording setup atput settings Frequency Acceleration Velocity Displacement Segment High abort High abor		
e directory ve/Recording setup utput settings Frequency Acceleration Velocity Displacement Segment High abort High a		1000
ve/Recording setup ve/Recording setup ve/Rec		
utput settings Frequency Acceleration Velocity Displacement Segment High abort High a		
	Y axis LogMag	•
Hz g m/s mm (pk-pk) type dB dB	dB -3	dB -6
Log-Lo V		-0
2 15.7609 1 0.0990284 2 6 3	-3	-6
2 13.7009 1 0.0990204 2 0 3		-0
3 2000 1 0.00078 0.000124203 6 3	-3	-6
	- 3	

Breakpoint Table: Breakpoints can be added via **Insert row**, **Delete row** and **Append row**. Use **Clear table** to clear out all rows except for the first and last row.

Insert row Delete row Append row Clear table Fill * Import/Export profile * Edit Table * Y axis LogMag *										
	4	Frequency Hz	Acceleration 9	Velocity m/s	Displacement mm (pk-pk)	Segment type	High abort d8	High alarm dB	Low alarm dB	Low abort dB
Þ.	1	5	0.100642	0.0314159	2		6	3	-3	-6
						Log-Lo 🗸				
	2	15.7609	1	0.0990284	2		6	3	-3	-6
						Const V				
	3	2000	1	0.00078	0.000124203		6	3	-3	-6

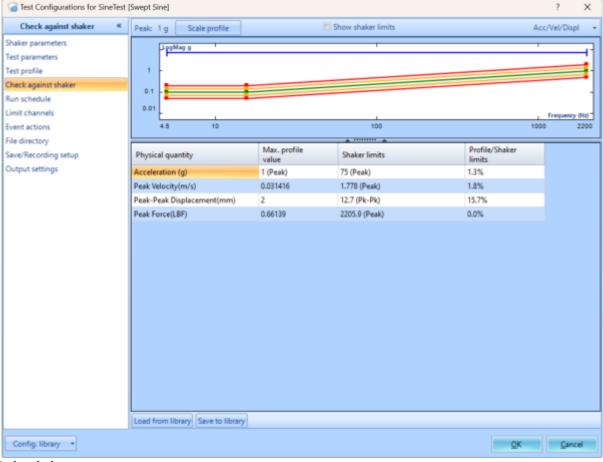
Breakpoint Calculation: In the profile editor, EDM can calculate the crossover point given a specified slope and point value. If a '?' is entered as a Frequency or Amplitude value, EDM will interpolate that value given the slope before and after that point.

vcs:sine

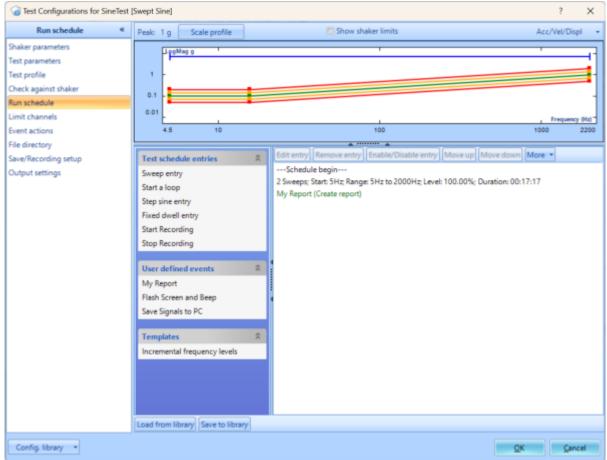


Segment Type::

Check Against Shaker



Run Schedule

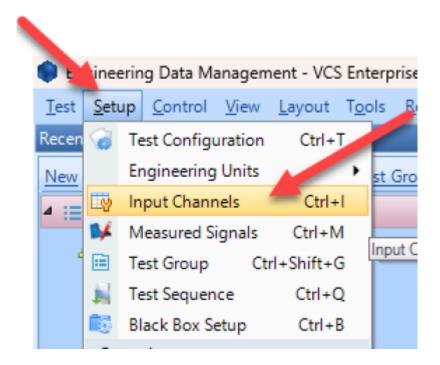


Sweep Entry:

Sweep Entry		?	×
Level (%):	100.00		
Sweep range —			
• Test profile (up)	Test profile (down) Custom		
Left frequency (Hz):	5 A Right frequency (Hz): 2000 A		
Start frequency (Hz):	5 Thitial sweep direction: Up		
Sweep rate			
Time per sweep	Sweep speed		
Time per sweep:	0000= 08= 38 (HH:MM:SS) Sweep speed: 1 (Oct/Min)		
Sweep#:	2 Total time: 0000: 17: 17 (HH:MN	1:SS)	
Total sine cycles:	3453812 +		
Hold sweep after ta	arget level reached.		
	Ωκ	<u>C</u> a	ncel

Input Channels

The input channels will now need to be set up. All sensors will to be properly configured before testing. The **Input Channels** menu can be found through **Setup** \rightarrow **Input Channels**.



Channel Type

Control vs. **Monitor**. When running a test, there will need to be at least one control sensor. The control sensor is used to monitor the actual vibration levels that the shaker is producing. It then sends this data to the controller so that it maintains the targeted profile. This sensor should be mounted somewhere on the shaker/slip table itself, not the Device Under Test (DUT). Monitor sensors will show the levels that the DUT itself is experiencing.

On/Off	Channel type	Location ID
🔽 On	Control 🗸	Ch1
🗸 On	Monitor ~	Ch2
Off	Monitor 🗸 🗸	Ch3
Off	Monitor 🗸 🗸	Ch4
Off	Monitor 🗸 🗸	Ch5
Off	Monitor 🗸 🗸	Ch6
Off	Monitor 🗸 🗸	Ch7
Off	Monitor 🗸 🗸	Ch8

Measurement Quantity

Defines the physical unit that will be measured by the sensor connected to the channel.

Measurement quantity Acceleration Acceleration Velocity Displacement Pressure Force Voltage Current Sound Pressure Time Frequency Angular Acceleratio Angular Velocity MASS Angle Moment Strain Temperature Resistance Humidity

Sensitivity

Sets the proportionality factor for the measurement (millivolts per engineering unit) given as a parameter of the sensor.**Input Mode**

There are five modes in which the inputs can operate:

DC-Differential- In the DC-Differential mode, neither of the input connections is referenced to the local ground. The input is taken as the potential difference between the two input terminals, and any potential in common with both terminals is canceled out. The Common Mode Voltage (CMV) will be rejected as long as the overall input voltage level does not saturate the input gain stage. Beware that very high CMV will cause clipping and may damage the input circuitry. Signals with a nonzero mean (DC component) can be measured in this mode.

DC-Single End- In single-ended mode, one of the input terminals is grounded and the input is taken as the potential difference of the center terminal with respect to this ground. Use this mode when the input needs to be grounded to reduce EMI noise or static buildup. Do not use this mode when the signal source is ground referenced or ground loop interference may result. This mode also allows signals with a non-zero mean to be measured.

AC-Differential- AC-Differential is a differential input mode that applies a low-frequency high-pass (DC-

11/12

blocking) analog filter to the input. It rejects common mode signals and DC components in the input signal. Use this when DC and low-frequency AC voltage measurements are not required or when a DC bias voltage is present. The analog high-pass filter has a cutoff frequency of -3dB at 0.3 Hz, and -0.1dB at 0.7 Hz for the IEPE input mode.

AC-Single End- AC-Single End grounds one of the input terminals and enables the DC-blocking analog filter. Use this mode for non-ground referenced sources where measuring the DC or low-frequency components are not required. It shares the same high-pass filter as that of AC-Differential.

IEPE (ICP)- All Crystal Instruments products support IEPE (Integral Electronic PiezoElectric) constant current output type input channels. IEPE refers to a class of transducers that are packaged with built-in voltage amplifiers powered by a constant current. These circuits are powered by a 4 mA constant current source at roughly 21 Volts.

Charge- Some sensors provide a high-impedance charge output. Usually, these are high-sensitivity piezoelectric units that lack a built-in voltage mode amplifier (i.e. IEPE), allowing them to be used in high-temperature environments. The Spider-81 front-end module has a built-in charge amplifier that allows the system to read the output of these sensors

Sensitivity	Input mode
100 (mV/g)	IEPE 🗸 .
100 (mV/g)	IEPE ~
100 (mV/g)	IEPE
100 (mV/g)	AC-Single End DC-Single End
100 (mV/g)	AC-Differential DC-Differential
100 (mV/g)	In-Line Charge Converte
100 (mV/g)	External Charge Amplifi External Charge Amplifi
100 (mV/g)	AC-Single End

Running the Test

Now that all of the parameters for the test have been setup, the test is ready to run. Here are the final steps to start the test.

- 1. Press the **Connect** button to connect to the controller.
- 2. Press the **Run** button.
- 3. The **Spider Check List** will now appear. Here you can check the settings of the test and verify that all is set up properly. Press **Start** once this has been verified.
- 4. The Pre-Test will now begin. This will verify that the control loop is properly established and provide data that the control loop needs.
- 5. The test is now running

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